

<b>Notice of References Cited</b>	Application/Control No. 10/665,156		Applicant(s)/Patent Under Reexamination LIN, WILLIAM	
	Examiner Maikhanh Nguyen		Art Unit 2176	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,085,206 A	07-2000	Domini et al.	715/533
*	B	US-6,131,102 A	10-2000	Potter, Douglas W.	715/533
*	C	US-6,558,431 B1	05-2003	Lynch et al.	715/513
*	D	US-7,028,259 B1	04-2006	Jacobson, Robert L.	715/531
*	E	US-2001/0032218 A1	10-2001	Huang, Evan S.	707/513
*	F	US-2002/0156816 A1	10-2002	Kantrowitz et al.	707/530
*	G	US-2003/0167446 A1	09-2003	Thomas, Semer Geoffrey	715/513
*	H	US-2004/0006744	01-2004	Jones et al.	715/514
*	I	US-2004/0268304 A1	12-2004	Kuo et al.	717/109
*	J	US-2005/0149867 A1	07-2005	Freeland et al.	715/533
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1004968 A1	05-2000	Europe	Canon Kabushiki Kaisha	
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U	C. Yoo et al., "Automatic Generation Algorithm of Uniform DTD for Structured Documents", Proceedings of the IEEE Region 10 Conference, September 1999, pp. 1095-1098.			
	V	A. Sahuguet, "Everything You Ever Wanted to Know About DTDs, But Were Afraid to Ask", WebDB Workshop, 2000, pp. 1.171-183.			
	W	H. De'Jean, "Learning Syntactic Structures with XML", in Processings of CoNLL-2000, 2000, pp. 133-135.			
	X	F. Bustamante et al., "GramCheck: A Grammar and Style Checker", pp. 1-7, No Dated.			

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.